NGTB15N135IHRWG

IGBT with Monolithic Free Wheeling Diode

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Field Stop (FS) Trench construction, and provides superior performance in demanding switching applications, offering both low on−state voltage and minimal switching loss. The IGBT is well suited for resonant or soft switching applications.

Features

- Extremely Efficient Trench with Fieldstop Technology
- 1350 V Breakdown Voltage
- Optimized for Low Case Temperature in IH Cooker Application
- Reliable and Cost Effective Single Die Solution
- These are Pb−Free Devices

Typical Applications

- Inductive Heating
- Consumer Appliances
- Soft Switching

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector−emitter voltage	V_{CES}	1350	V
Collector current @ T_C = 25°C @ T_C = 100°C	I_C	 30 15	A
Pulsed collector current, T_{pulse} limited by T_{Jmax}	I_{CM}	60	A
Diode forward current @ T_C = 25°C @ T_C = 100°C	I_F	 30 15	A
Diode pulsed current, T_{pulse} limited by T_{Jmax}	I_{FM}	60	A
Gate−emitter voltage Transient Gate−emitter Voltage (T_{pulse} = 5 μs, D < 0.10)	V_{GE}	±20 ±25	V
Power Dissipation @ T_C = 25°C @ T_C = 100°C	P_D	 357 178	W
Operating junction temperature range	T_J	−40 to +175	°C
Storage temperature range	T_{stg}	−55 to +175	°C
Lead temperature for soldering, 1/8” from case for 5 seconds	T_{SLD}	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

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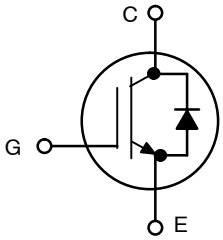
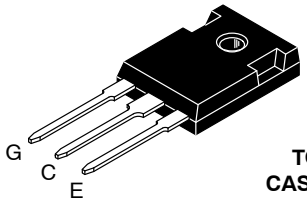
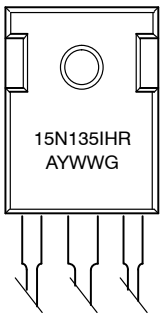
15 A, 1350 V
V_{CEsat} = 2.15 V
E_{off} = 0.42 mJ





TO−247
CASE 340AL

MARKING DIAGRAM



A = Assembly Location
Y = Year
WW = Work Week
G = Pb−Free Package

ORDERING INFORMATION

Device	Package	Shipping
NGTB15N135IHRWG	TO−247 (Pb−Free)	30 Units / Rail

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THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction−to−case	$R_{\theta JC}$	0.42	°C/W
Thermal resistance junction−to−ambient	$R_{\theta JA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
STATIC CHARACTERISTIC						
Collector−emitter breakdown voltage, gate−emitter short−circuited	V_{GE} = 0 V, I_C = 500 μA	$V_{(BR)CES}$	1350	–	–	V
Collector−emitter saturation voltage	V_{GE} = 15 V, I_C = 15 A V_{GE} = 15 V, I_C = 15 A, T_J = 175°C	V_{CEsat}	– –	2.15 2.25	2.65 –	V
Gate−emitter threshold voltage	V_{GE} = V_{CE}, I_C = 250 μA	$V_{GE(th)}$	4.5	5.5	6.5	V
Collector−emitter cut−off current, gate−emitter short−circuited	V_{GE} = 0 V, V_{CE} = 1350 V	I_{CES}	–	–	0.1	mA
Gate leakage current, collector−emitter short−circuited	V_{GE} = 20 V, V_{CE} = 0 V	I_{GES}	–	–	100	nA
DYNAMIC CHARACTERISTIC						
Input capacitance	V_{CE} = 20 V, V_{GE} = 0 V, f = 10 kHz	C_{ies}	–	3560	–	pF
Output capacitance		C_{oes}	–	87	–	
Reverse transfer capacitance		C_{res}	–	68	–	
Gate charge total	V_{CE} = 600 V, I_C = 15 A, V_{GE} = 15 V	Q_g	–	156	–	nC
Gate to emitter charge		Q_{ge}	–	27	–	
Gate to collector charge		Q_{gc}	–	70	–	
SWITCHING CHARACTERISTIC, INDUCTIVE LOAD						
Turn−off delay time	T_J = 25°C V_{CC} = 600 V, I_C = 15 A R_g = 10 Ω V_{GE} = 0 V/ 15V	$t_{d(off)}$	–	170	–	ns
Fall time		t_f	–	200	–	
Turn−off switching loss		E_{off}	–	0.42	–	mJ
Turn−off delay time	T_J = 150°C V_{CC} = 600 V, I_C = 15 A R_g = 10 Ω V_{GE} = 0 V/ 15V	$t_{d(off)}$	–	190	–	ns
Fall time		t_f	–	290	–	
Turn−off switching loss		E_{off}	–	0.95	–	mJ
DIODE CHARACTERISTIC						
Forward voltage	V_{GE} = 0 V, I_F = 15 A, T_J = 25°C V_{GE} = 0 V, I_F = 15 A, T_J = 175°C	V_F	– –	1.85 2.75	2.10 –	V

TYPICAL CHARACTERISTICS

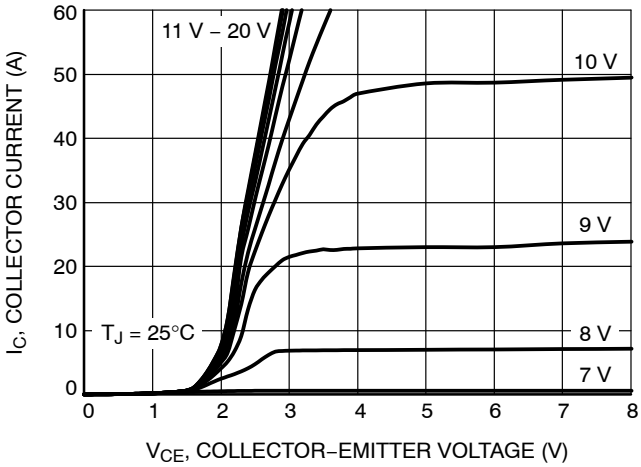

Figure 1. Output Characteristics

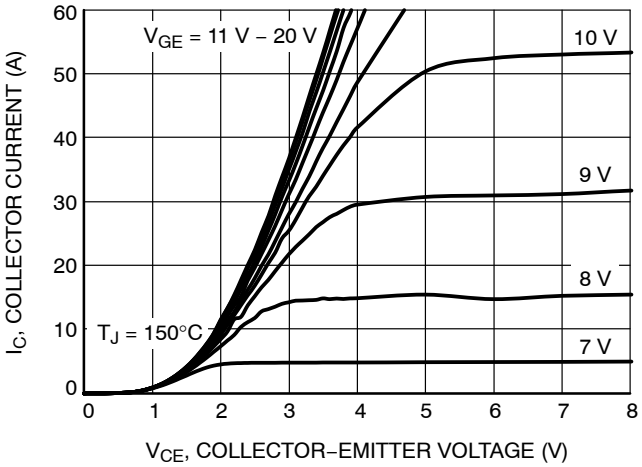

Figure 2. Output Characteristics

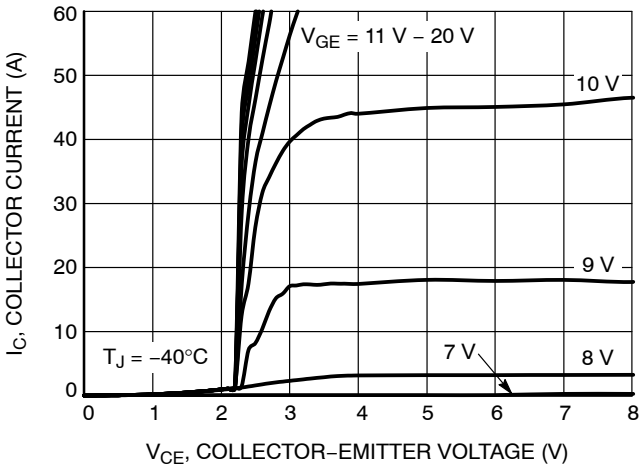

Figure 3. Output Characteristics

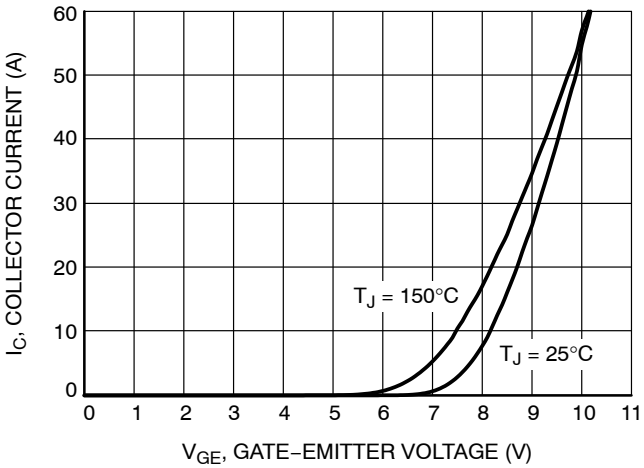

Figure 4. Typical Transfer Characteristics

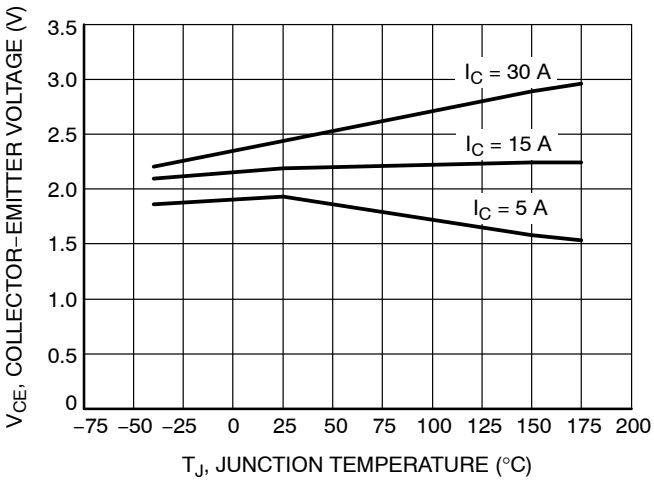

Figure 5. $V_{CE(sat)}$ vs. T_J

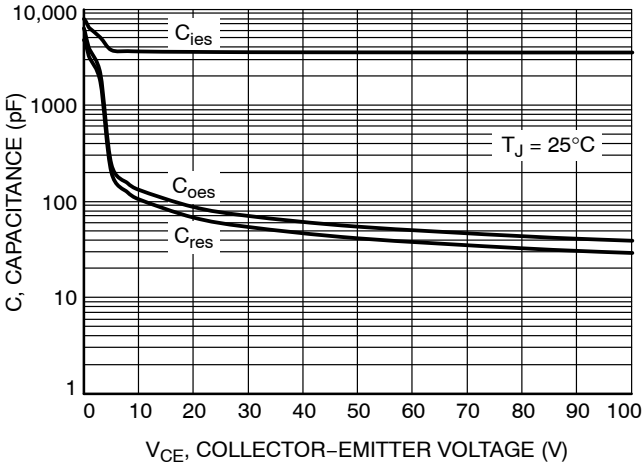

Figure 6. Typical Capacitance

TYPICAL CHARACTERISTICS

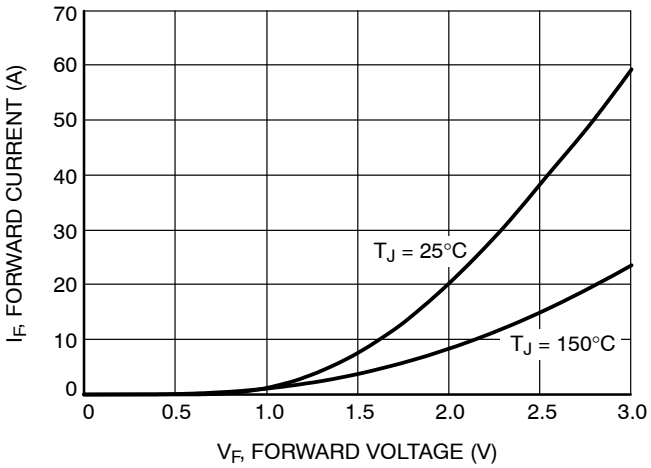

Figure 7. Diode Forward Characteristics

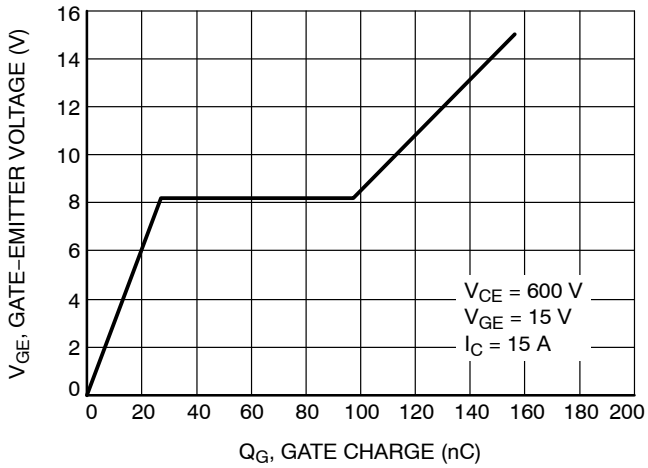

Figure 8. Typical Gate Charge

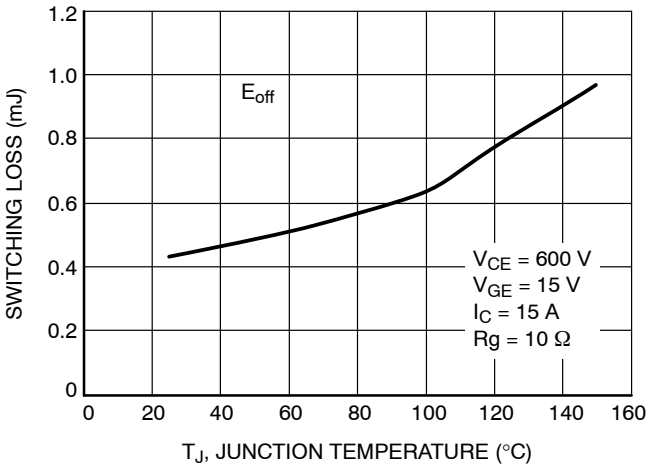

Figure 9. Switching Loss vs. Temperature

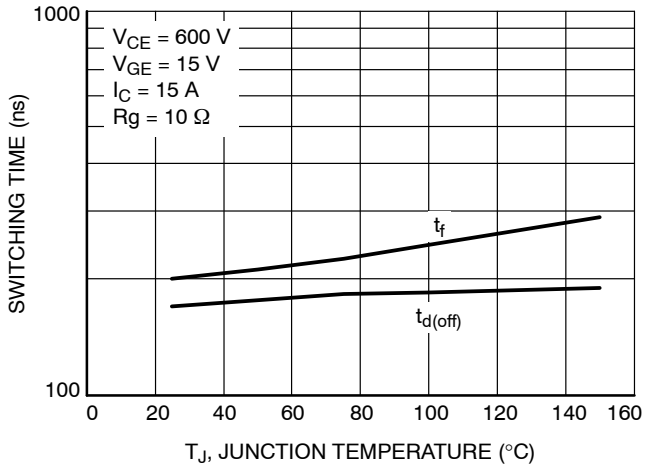

Figure 10. Switching Time vs. Temperature

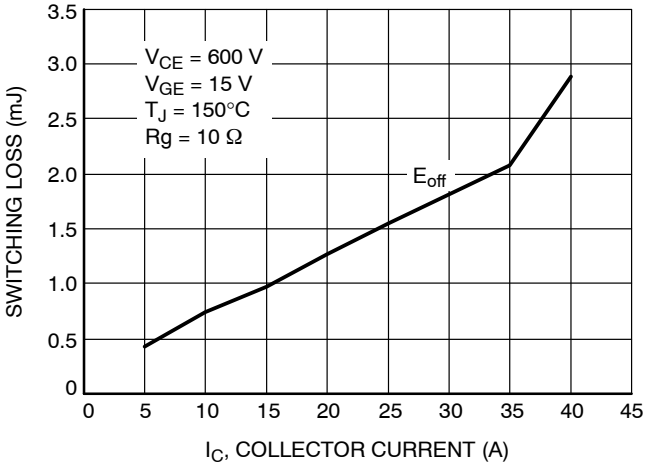

Figure 11. Switching Loss vs. I_C

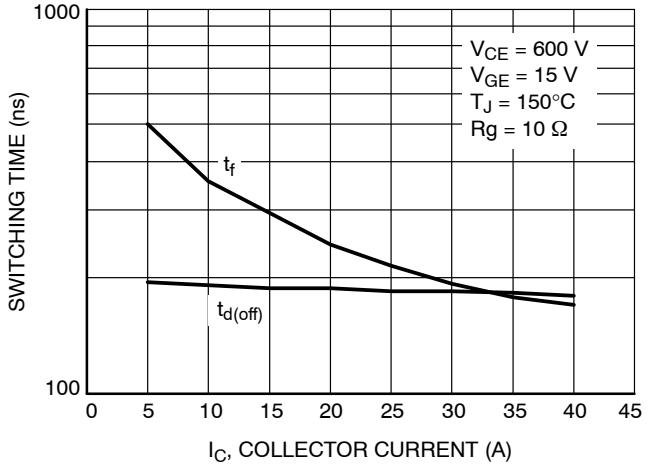

Figure 12. Switching Time vs. I_C

TYPICAL CHARACTERISTICS

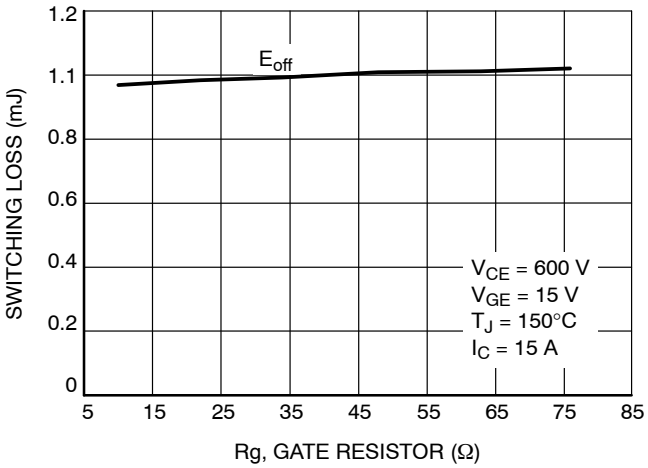

Figure 13. Switching Loss vs. Rg

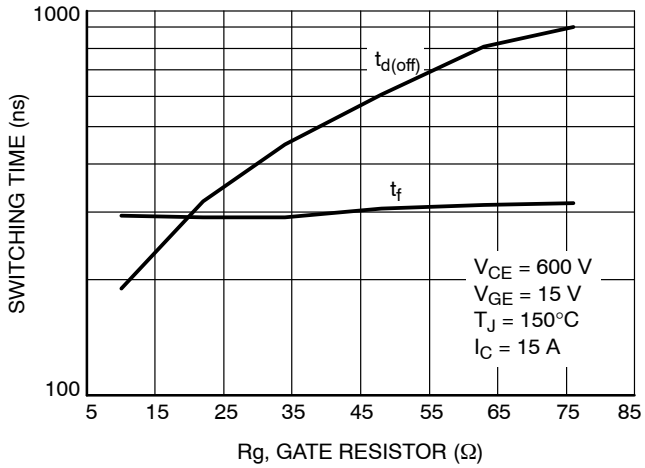

Figure 14. Switching Time vs. Rg

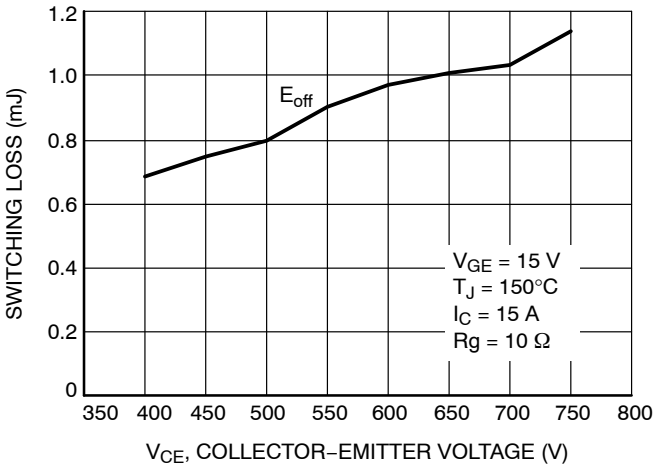

Figure 15. Switching Loss vs. V_{CE}

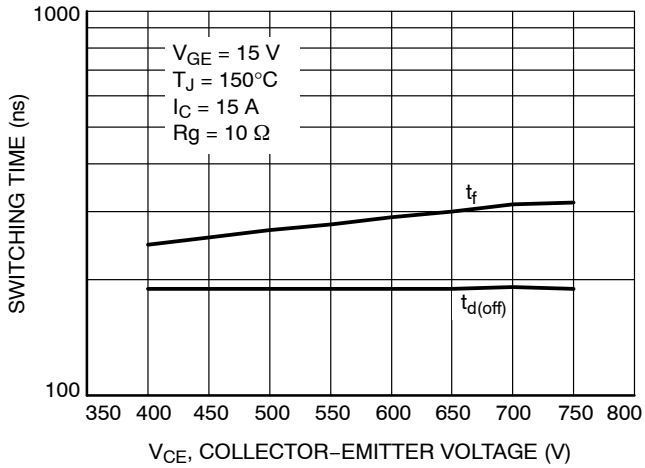

Figure 16. Switching Time vs. V_{CE}

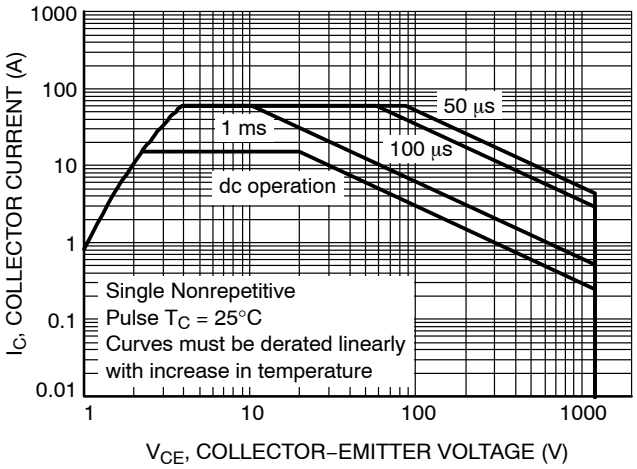

Figure 17. Safe Operating Area

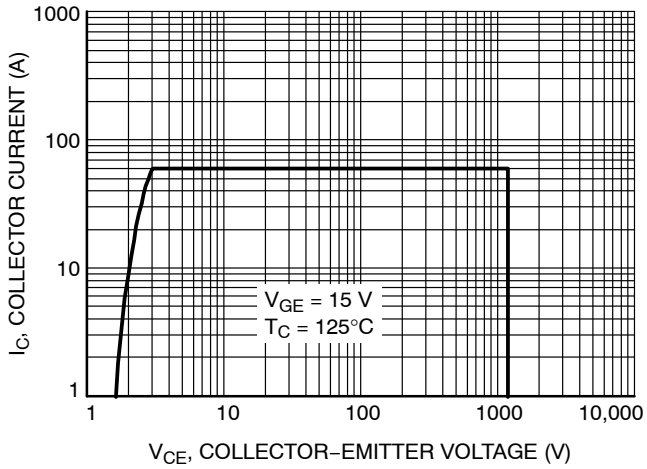

Figure 18. I_C vs. V_{CE}

TYPICAL CHARACTERISTICS

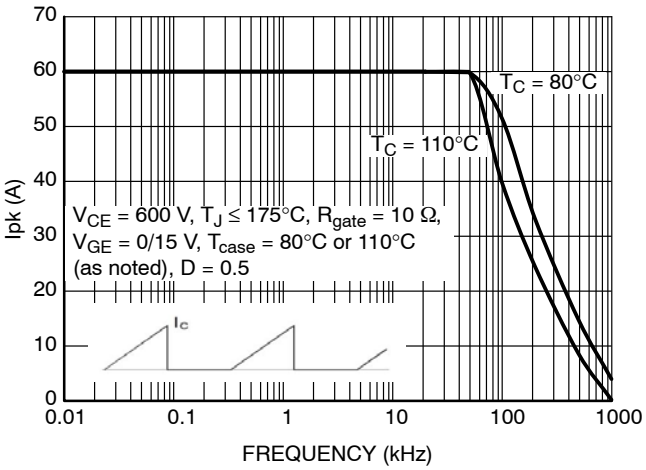

Figure 19. Collector Current vs. Switching Frequency

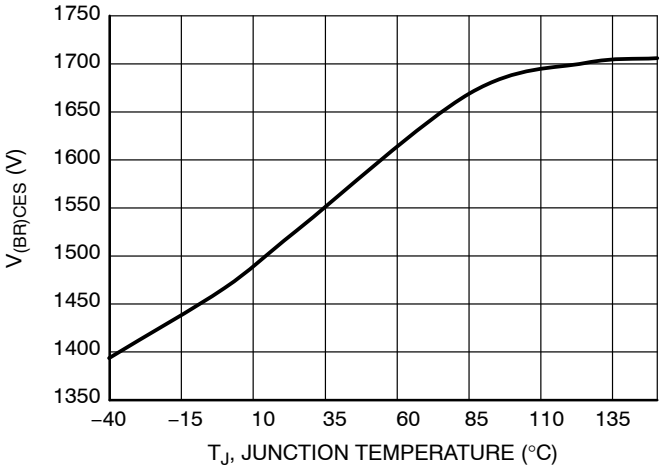

Figure 20. Typical $V_{(BR)CES}$ vs. Temperature

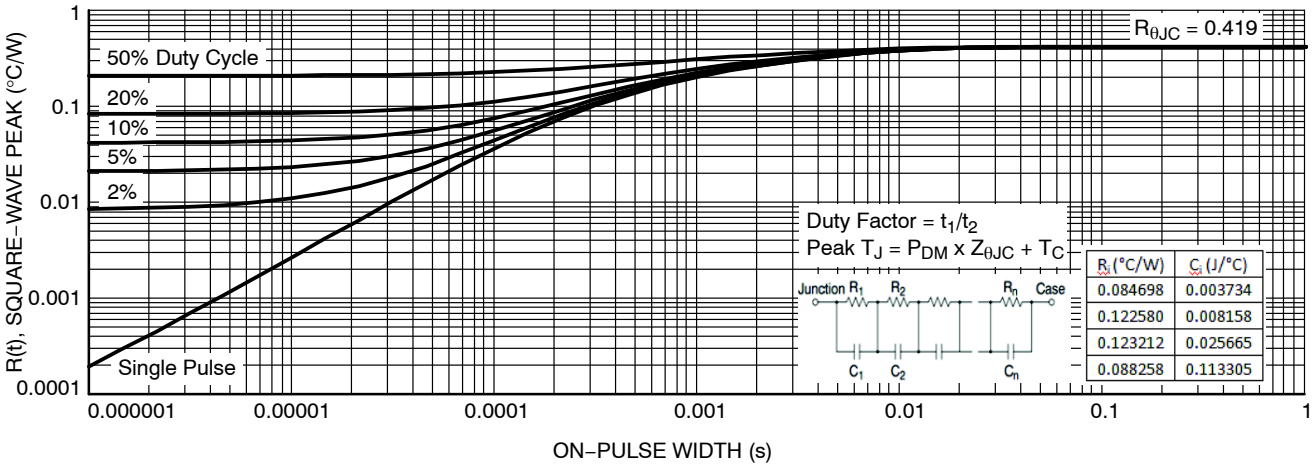

Figure 21. IGBT Transient Thermal Impedance

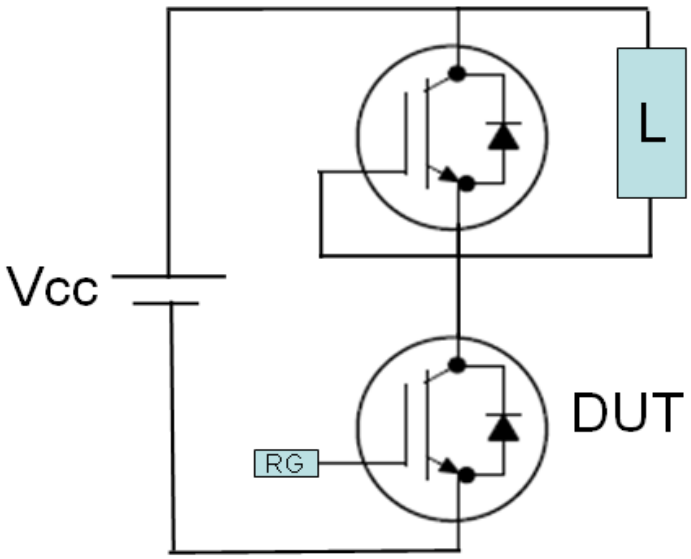

Figure 22. Test Circuit for Switching Characteristics

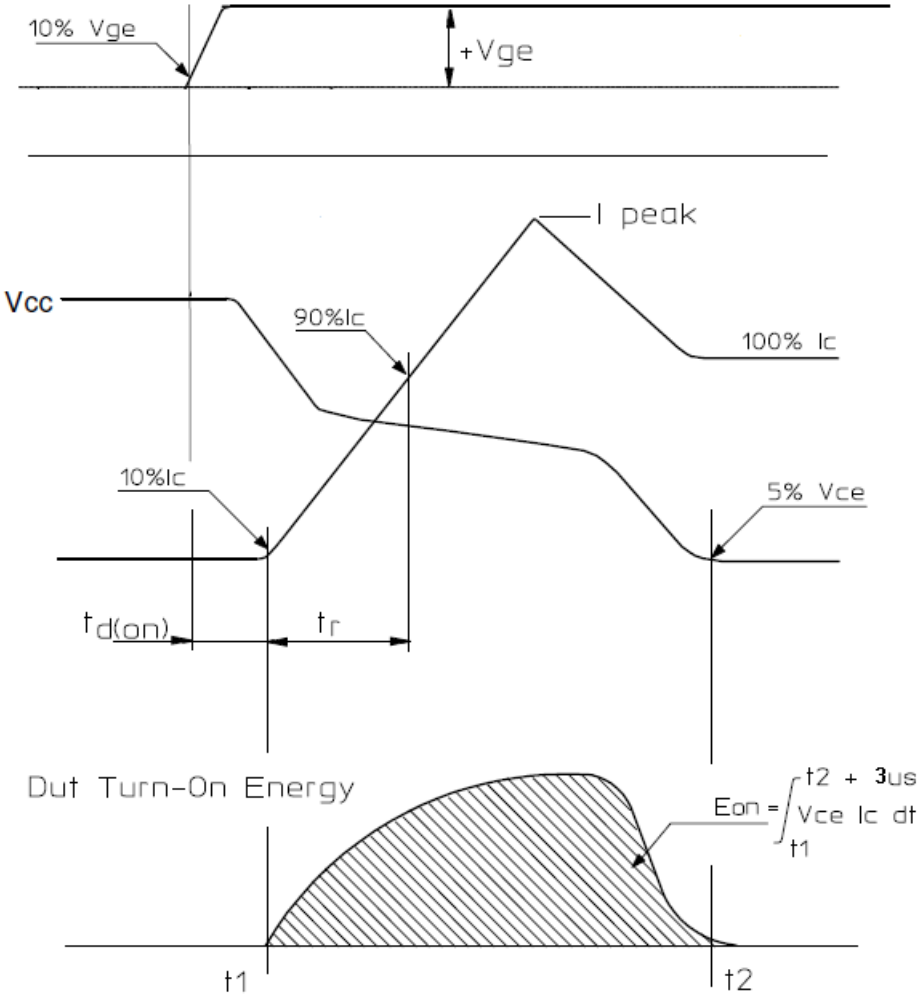

Figure 23. Definition of Turn On Waveform

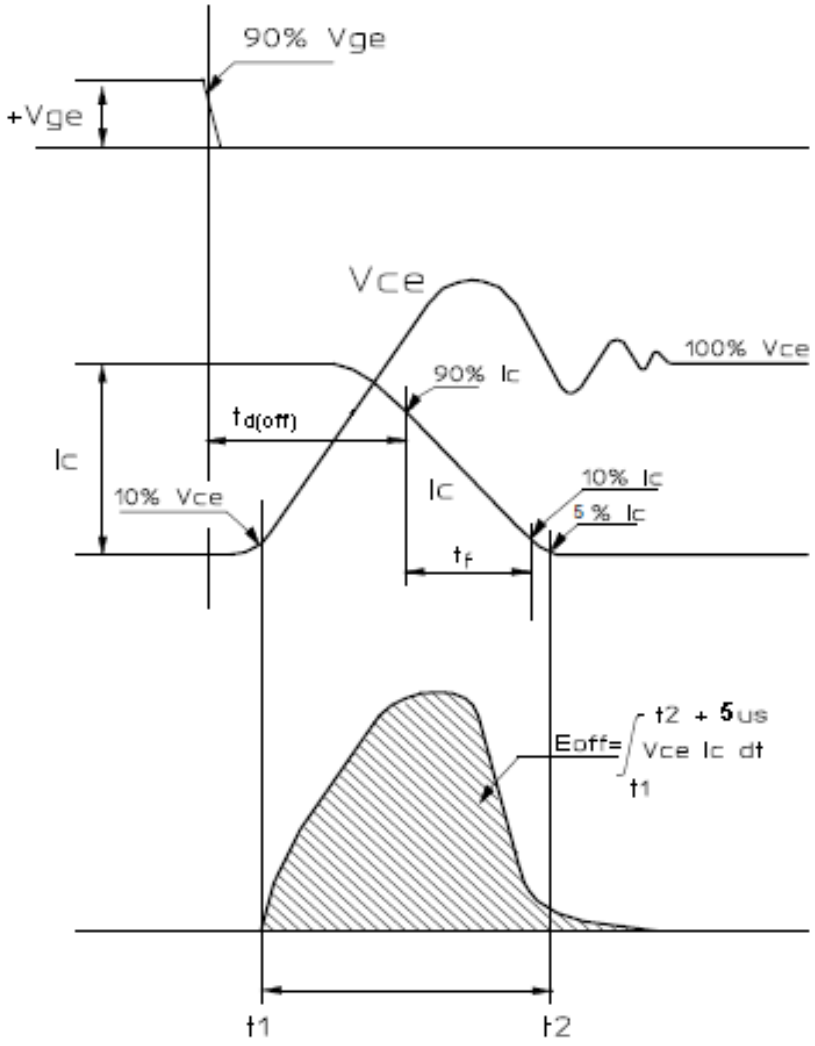

Figure 24. Definition of Turn Off Waveform

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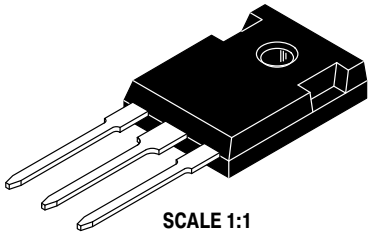
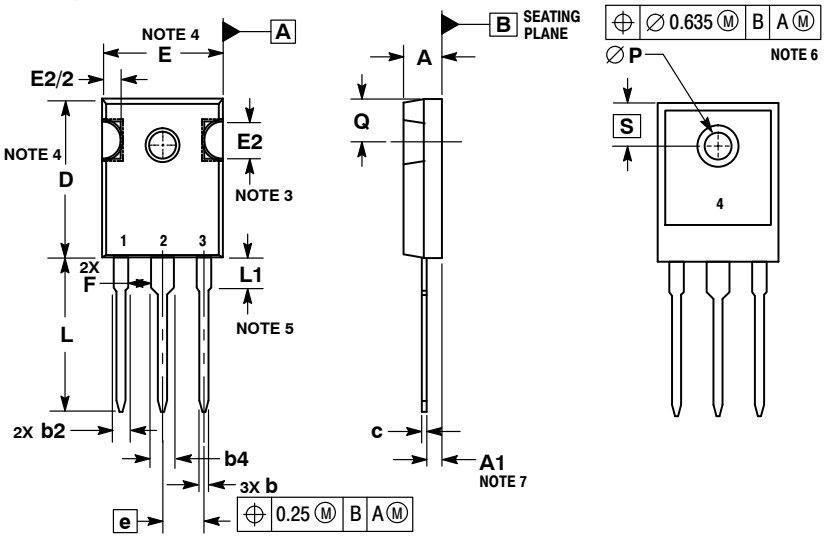
DATE 17 MAR 2017



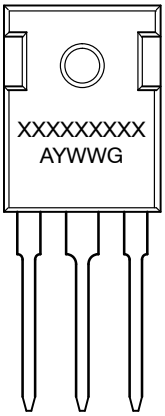
SCALE 1:1



NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. SLOT REQUIRED, NOTCH MAY BE ROUNDED.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREME OF THE PLASTIC BODY.
5. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.
6. ∅P SHALL HAVE A MAXIMUM DRAFT ANGLE OF 1.5° TO THE TOP OF THE PART WITH A MAXIMUM DIAMETER OF 3.91.
7. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.

	MILLIMETERS	
DIM	MIN	MAX
A	4.70	5.30
A1	2.20	2.60
b	1.07	1.33
b2	1.65	2.35
b4	2.60	3.40
c	0.45	0.68
D	20.80	21.34
E	15.50	16.25
E2	4.32	5.49
e	5.45 BSC	
F	2.655	---
L	19.80	20.80
L1	3.81	4.32
P	3.55	3.65
Q	5.40	6.20
S	6.15 BSC	

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
G = Pb−Free Package

*This information is generic. Please refer to device data sheet for actual part marking.
Pb−Free indicator, “G” or microdot “ ▪”, may or may not be present.

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